9

to the detector is opened and after an appropriate integration interval the residual charge pattern on the charge coupled detector array is interrogated to generate a signal relating to the charge pattern for processing and storage as aforesaid.

REMARKS

The above amendments are being made in order to eliminate multiple dependency and improper multiple dependency before calculation of the national filing for the United States. Should any multiple dependency remain, that is unintended, and the Patent and Trademark Office is requested to cancel any remaining multiple dependent claims before calculation of the national filing fee for the United States.

Examination of the application on its merits is awaited.

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Respectfully submitted,

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